

Notice of References Cited	Application/Control No. 10/803,795	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Jason M. Han	Art Unit 2875	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,870,319	03-2005	Kayano et al.	315/82
*	B	US-6,618,323	09-2003	Kayano et al.	367/96
*	C	US-4,630,226	12-1986	Tanaka, Haruto	702/103
*	D	US-4,722,547	02-1988	Kishi et al.	367/96
*	E	US-6,480,806	11-2002	Bilz et al.	702/154
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2003025905A	01-2003	Japan	Kayano et al.	B60Q 1/10
	O	JP2000318514A	11-2000	Japan	Kimura et al.	B60Q 1/115
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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